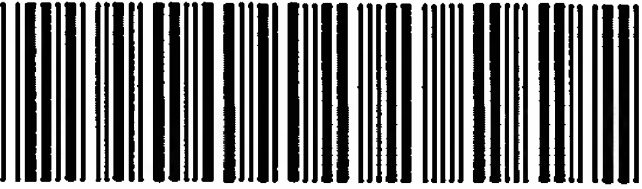


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/653,300	WU ET AL.	
	Examiner	Art Unit	
	Christian A. Hannon	2685	

SEARCHED			
Class	Subclass	Date	Examiner
455	313	2/2/06	CH
455	334		
375	316		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted with Ed Urban & Quochien Vuong	2/2/06	CH